

CMOS Analog Switches

(Obsolete for non-hermetic. See DG381B Series for pin-for-pin replacements.)

FEATURES

- $\pm 15\text{-V}$ Input Range
- Low $r_{DS(on)}$: $30\ \Omega$
- Single Supply Operation
- Pin and Function Compatible with the JFET DG180 Family

BENEFITS

- Full Rail-to-Rail Analog Signal Range
- Minimizes Signal Error
- Low Power Dissipation

APPLICATIONS

- Low Level Switching Circuits
- Programmable Gain Amplifiers
- Portable and Battery Powered Systems

DESCRIPTION

The DG384A_MIL and DG387A_MIL monolithic CMOS analog switches were designed for applications in instrumentation, communications, and process control. This series is suited for applications requiring fast switching and nearly flat on-resistance over the entire voltage range.

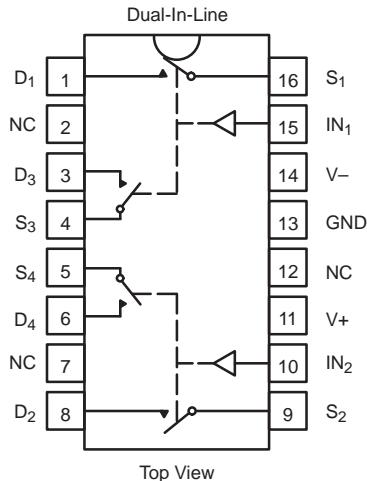
Designed on Vishay Siliconix' PLUS-40 CMOS process, these devices achieve low power consumption (3.5 mW typical) and excellent on/off switch performance. These

switches are ideal for battery powered applications, without sacrificing switching speed. Break-before-make switching action is guaranteed, and an epitaxial layer prevents latchup. Single supply operation is allowed by connecting the V₋ rail to 0 V.

Each switch conducts equally well in both directions when on, and blocks up to the supply voltage when off. These switches are CMOS and quasi TTL logic compatible.

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION

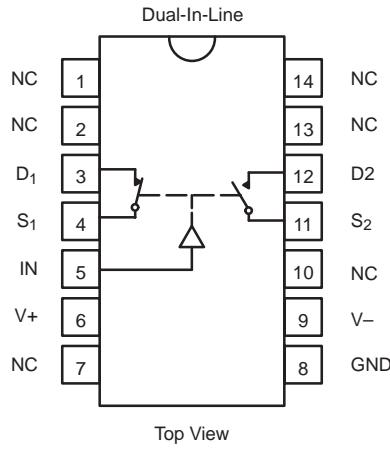
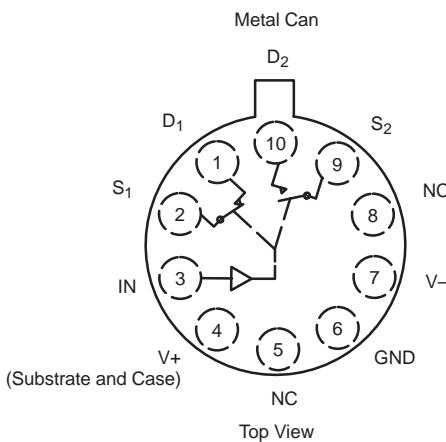
DG384A_MIL



TRUTH TABLE

Logic	Switch
0	OFF
1	ON

Logic "0" $\leq 0.8\text{ V}$
Logic "1" $\geq 4\text{ V}$

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION**DG387A_MIL****DG387A_MIL****TRUTH TABLE**

Logic	SW ₁	SW ₂
0	ON	OFF
1	OFF	ON

Logic "0" \leq 0.8 V
 Logic "1" \geq 4 V

ORDERING INFORMATION

Temp Range	Package	Part Number
DG384A_MIL		
-55 to 125°C	16-Pin CerDIP	DG384AAK/883 5962-9678801QEA
DG387A_MIL		
-55 to 125°C	14-Pin CerDIP	DG387AAK/883
	10-Pin Metal Can	DG387AAA/883

ABSOLUTE MAXIMUM RATINGS

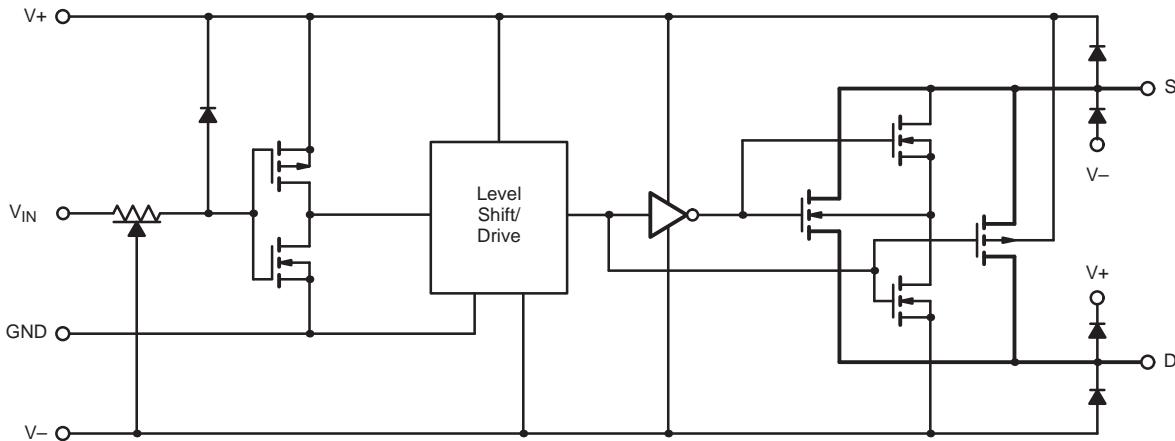
Voltages Referenced to V-	
V+ 44 V
GND 25 V
Digital Inputs ^a , V _S , V _D	(V-) -2 V to (V+) +2V or 30 mA, whichever occurs first
Current, Any Terminal Except S or D 30 mA
Continuous Current, S or D 30 mA
(Pulsed at 1 ms, 10% duty cycle max) 100 mA
Storage Temperature (AA, AK, Suffix) -65 to 150°C

Power Dissipation^b

14-Pin CerDIP ^c 825 mW
10-Pin Metal Can ^d 450 mW

Notes:

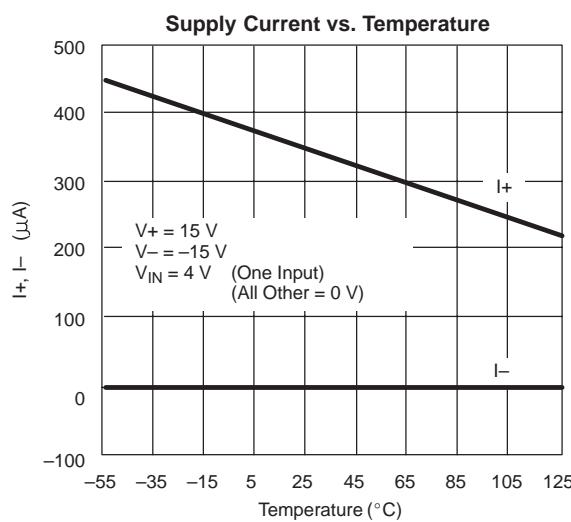
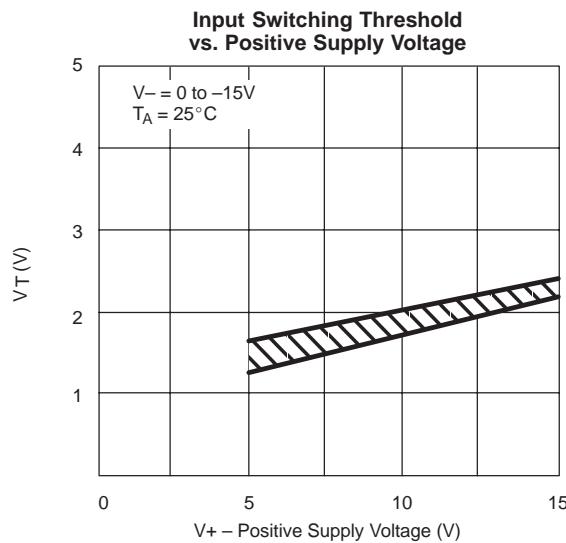
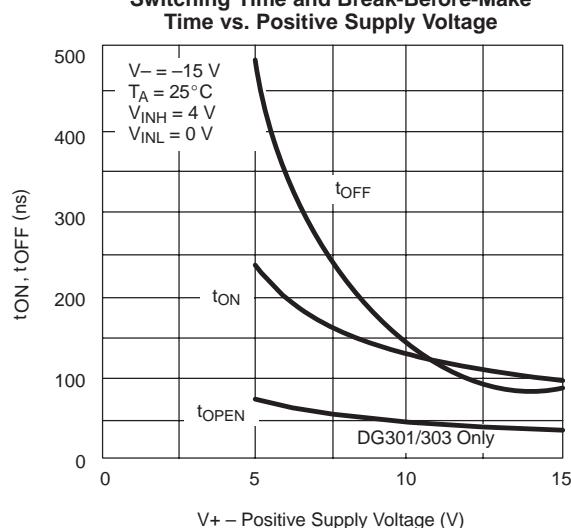
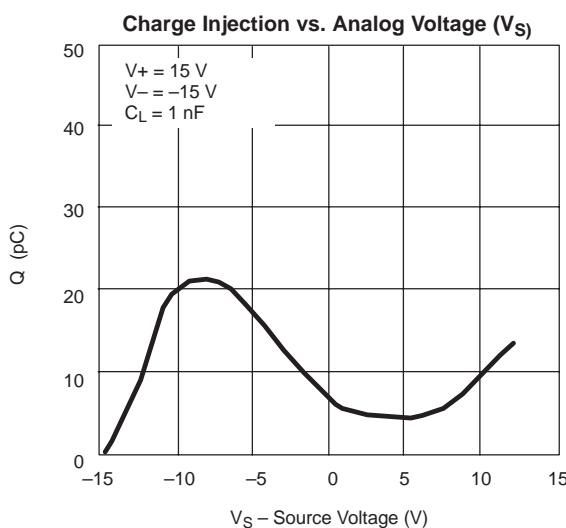
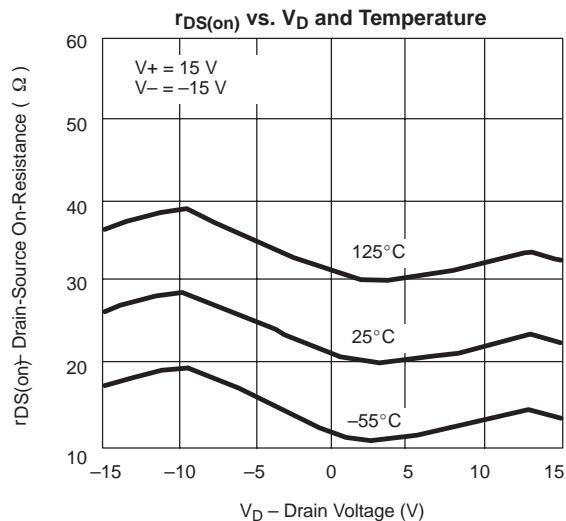
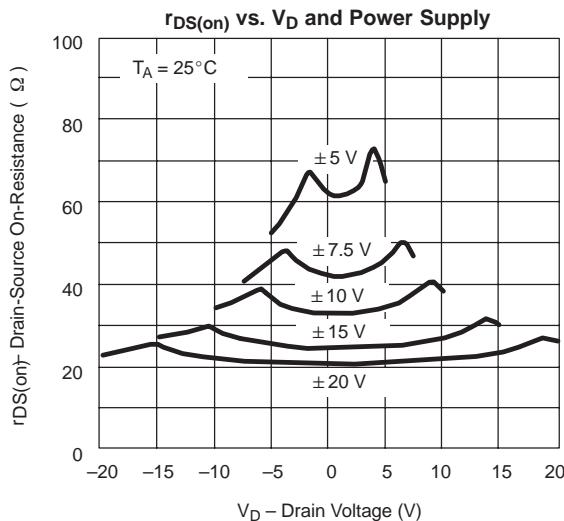
- a. Signals on S_X, D_X, or IN_X exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads welded or soldered to PC Board.
- c. Derate 11 mW/°C above 75°C
- d. Derate 6 mW/°C above 75°C

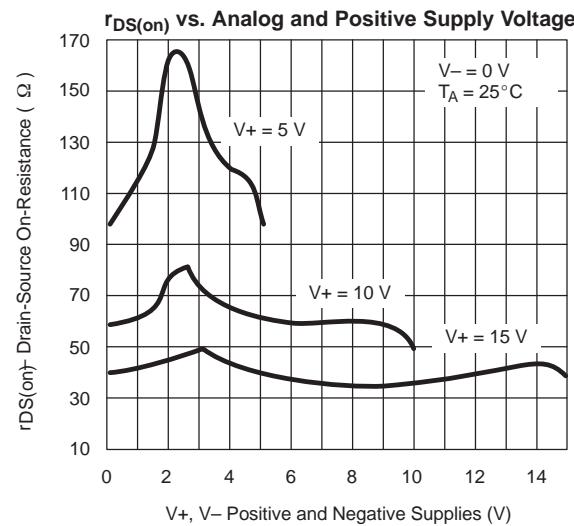
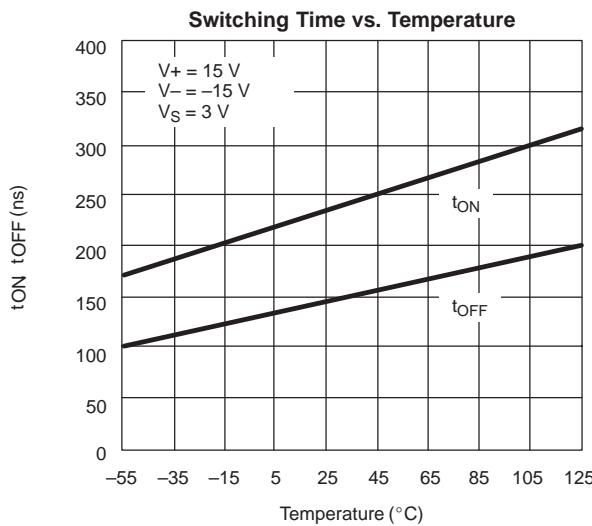
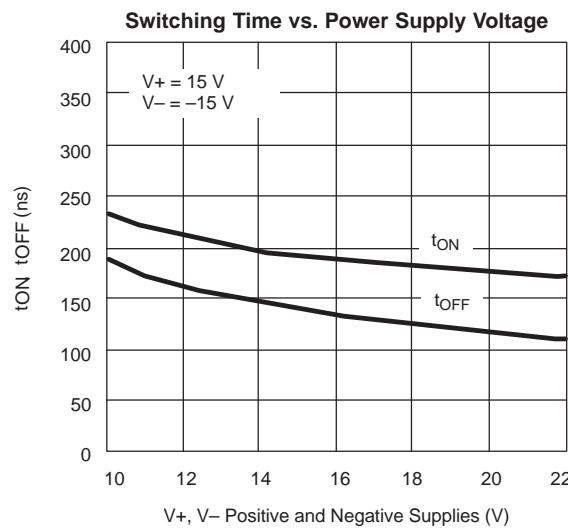
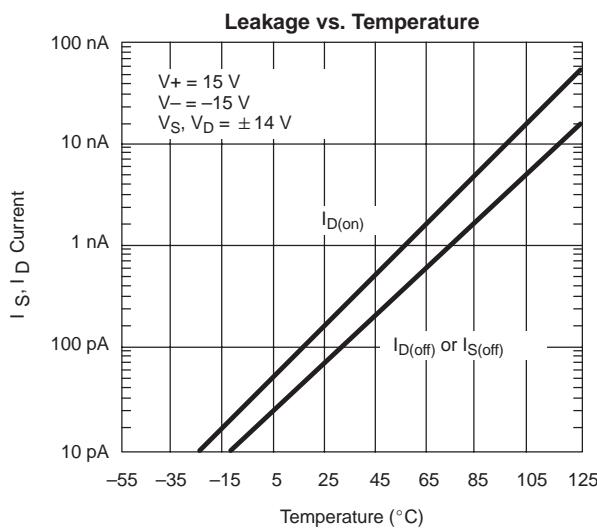
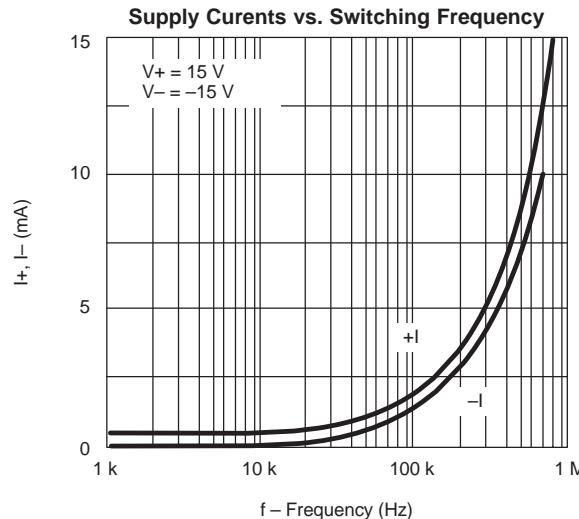
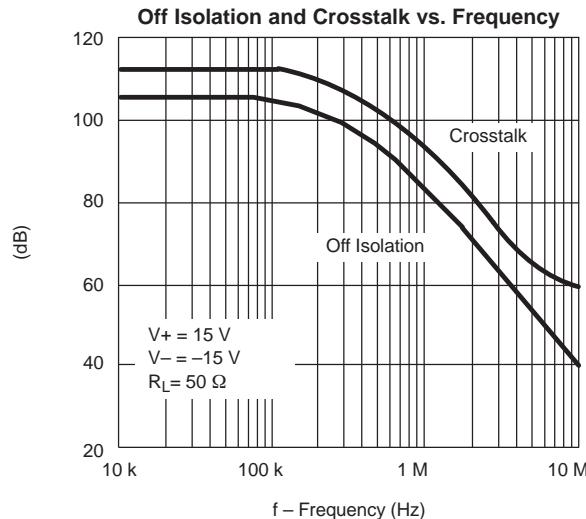
SCHEMATIC DIAGRAM (TYPICAL CHANNEL)

FIGURE 1.

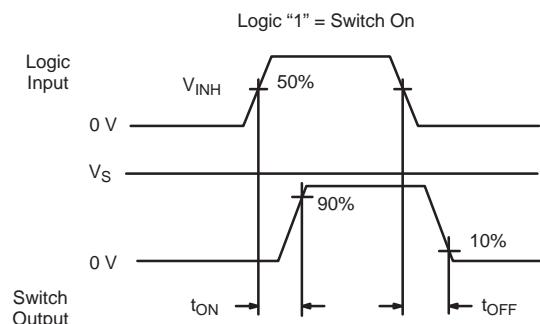
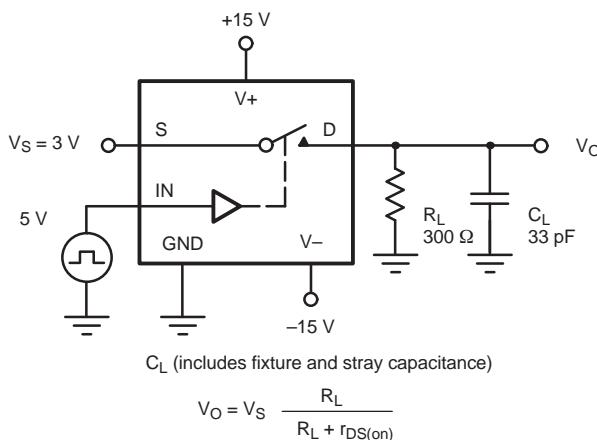
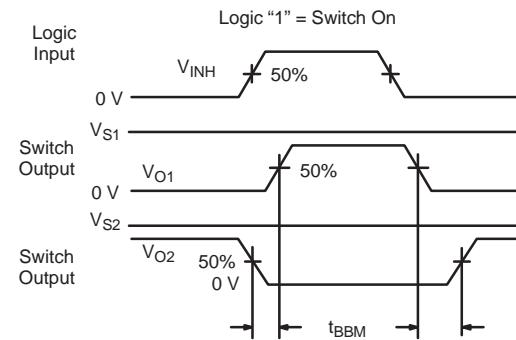
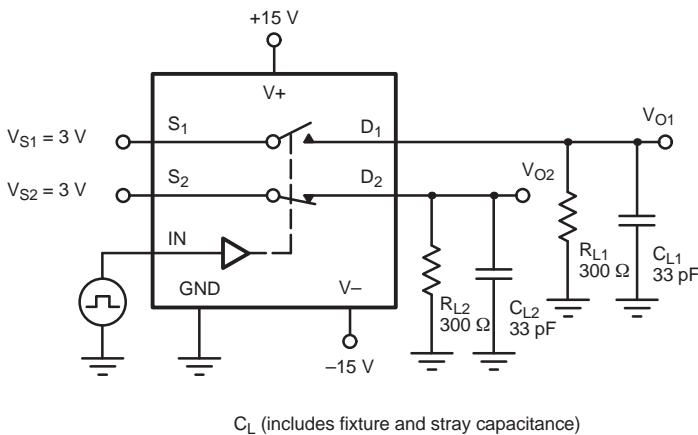
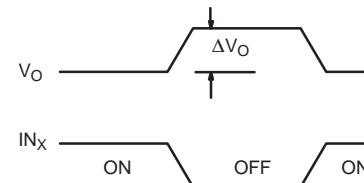
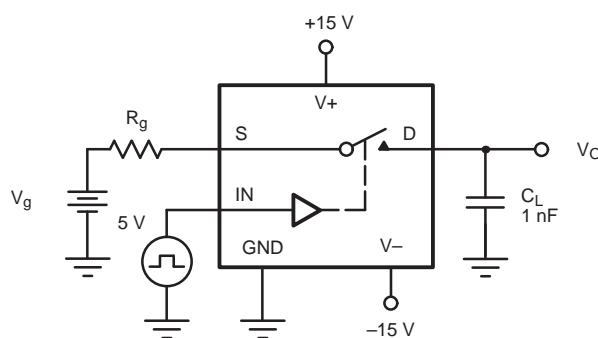
SPECIFICATIONS ^a							
Parameter	Symbol	Test Conditions Unless Specified $V_+ = 15 \text{ V}$, $V_- = -15 \text{ V}$ $V_{IN} = 0.8 \text{ V}$ or 4 V^f	Temp ^b	Limits			Unit
				Min ^c	Typ ^d	Max ^c	
Analog Switch							
Analog Signal Range ^e	V_{ANALOG}		Full	-15		15	V
Drain-Source On-Resistance	$r_{DS(on)}$	$V_D = \pm 10 \text{ V}$, $I_S = -10 \text{ mA}$	Room Full		30	50 75	Ω
Source Off Leakage Current	$I_{S(off)}$	$V_S = \pm 14 \text{ V}$, $V_D = \mp 14 \text{ V}$	Room Hot	-1 -100	± 0.1	1 100	nA
Drain Off Leakage Current	$I_{D(off)}$	$V_S = \pm 14 \text{ V}$, $V_D = \mp 14 \text{ V}$	Room Hot	-1 -100	± 0.1	1 100	
Drain On Leakage Current	$I_{D(on)}$	$V_D = V_S = \pm 14 \text{ V}$	Room Hot	-11 -100	± 0.1	1 100	
Digital Control							
Input Current with Input Voltage High	I_{INH}	$V_{IN} = 5 \text{ V}$	Room Full	-1 -1	-0.001		μA
		$V_{IN} = 15 \text{ V}$	Room Full		0.001	1 1	
Input Current with Input Voltage Low	I_{INL}	$V_{IN} = 0 \text{ V}$	Room Full	-1 -1	-0.001		
Dynamic Characteristics							
Turn-On Time	t_{ON}	See Figure 2	Room		150	300	ns
Turn-Off Time	t_{OFF}		Room		130	250	
Break-Before-Make Time	t_{OPEN}	See Figure 3	Room		50		
Charge Injection	Q	$C_L = 0.01 \mu\text{F}$, $R_{gen} = 0 \Omega$, $V_{gen} = 0 \text{ V}$	Room		10		pC
Source-Off Capacitance	$C_{S(off)}$	$f = 1 \text{ MHz}$; V_S , $V_D = 0 \text{ V}$	Room		14		pF
Drain-Off Capacitance	$C_{D(off)}$		Room		14		
Channel-On Capacitance	$C_{D(on)}$		Room		40		
Input Capacitance	C_{IN}	$f = 1 \text{ MHz}$	$V_{IN} = 0 \text{ V}$	Room	6		dB
			$V_{IN} = 15 \text{ V}$	Room	7		
Off-Isolation	$OIRR$	$V_{IN} = 0 \text{ V}$, $R_L = 1 \text{ k}\Omega$ $V_S = 1 \text{ V}_{rms}$, $f = 500 \text{ kHz}$	Room		62		
Crosstalk (Channel-to-Channel)	X_{TALK}		Room		74		
Power Supplies							
Positive Supply Current	I_+	$V_{IN} = 4 \text{ V}$ (One Input) (All Others = 0)	Room Full		0.23	0.5 1.0	mA
Negative Supply Current	I_-		Room Full	-10 -100	-0.001		μA
Positive Supply Current	I_+	$V_{IN} = 0.8 \text{ V}$ (All Inputs)	Room Full		0.001	10 100	
Negative Supply Current	I_-		Room Full	-10 -100	-0.001		

Notes:

- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25°C , Full = as determined by the operating temperature suffix.
- c. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- d. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- e. Guaranteed by design, not subject to production test.
- f. V_{IN} = input voltage to perform proper function.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)


TEST CIRCUITS

FIGURE 2. Switching Time

FIGURE 3. Break-Before-Make SPDT
(DG387A_MIL)

FIGURE 4. Charge Injection

APPLICATIONS

The DG384A_MIL and DG387A_MIL will switch positive analog signals while using a single positive supply. This allows their use in applications where only one supply is available. The trade-offs or performance given up while using single supplies are: 1) increased $r_{DS(on)}$, 2) slower switching speed. Typical curves for aid in designing with single supplies are supplied (see Typical Characteristics). The analog voltage should not go above or below the supply voltages which in single operation are V+ and 0 V.

In the integrator of Figure 4, R_D controls the discharge rate of the capacitor so that the pulsed or continuous current ratings are not exceeded. During reset SW₁ is closed and SW₂ is open. Opening SW₂ with SW₁ also open will hold the integrator output at its present value.

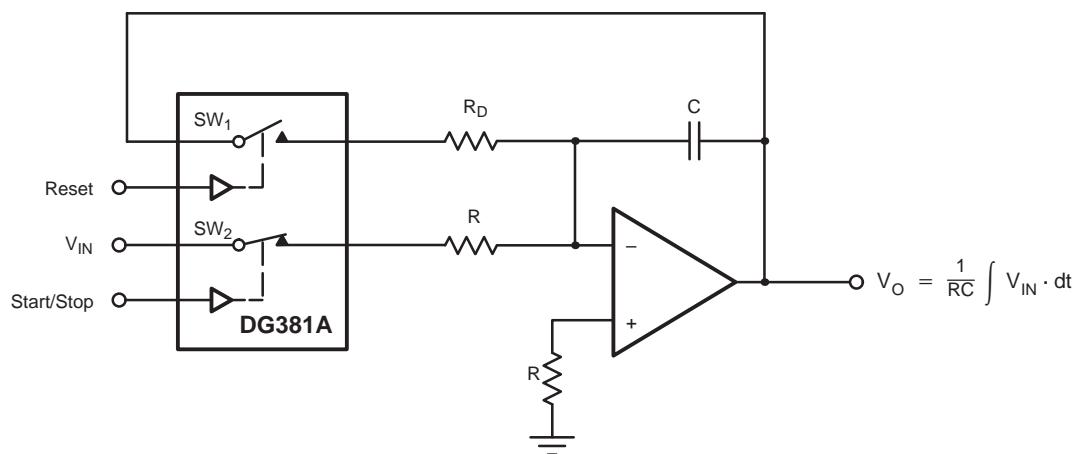


FIGURE 5. Integrator with Reset and Start/Stop

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